





# Field Emission and Multipactor Simulations in High-Gradient RF Accelerators

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- Introduction
- Longitudinal Dark Current
- Transversal Dark Current & Multipactor
- Multipactor in SiC loads
- Conclusions

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# Introduction

#### Effect of field emission on high gradient operation

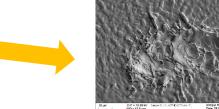
- Initially emitted in the high field areas of the structure, field emitted electrons are captured by the RF fields over a certain gradient threshold. This produces the dark current: causing radiation during test, even without beam, and possibly distorting BPM measurements.
- Field emission can turn into an explosive process causing the damaging breakdowns that limit HG performance.
- Field emission also causes electron seeding in low field areas potentially triggering Multipactor effect.

Beam Position Monitor. CLIC Project Implementation Plan. CERN. 2018.
Microscope picture from Enrique Rodriguez Castro.
Burnings in a low pass filter caused by Multipactor, picture from Benito Gimeno.

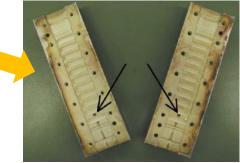












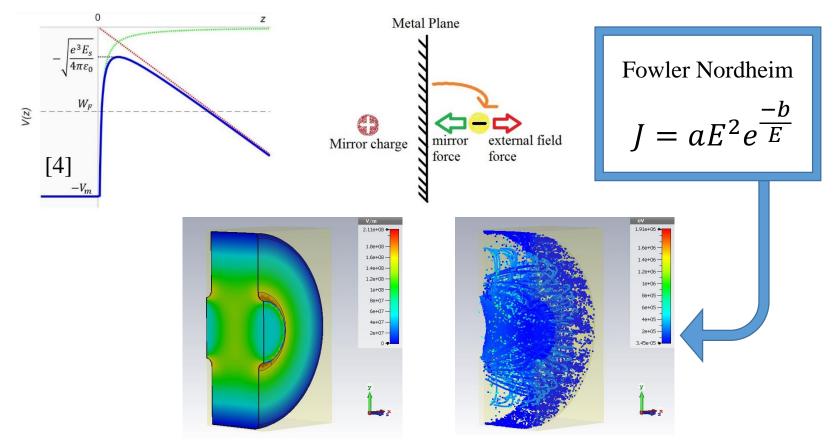
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[3]

## Introduction

#### Field emission theory

Quantum tunneling of the potential barrier gives an electron current



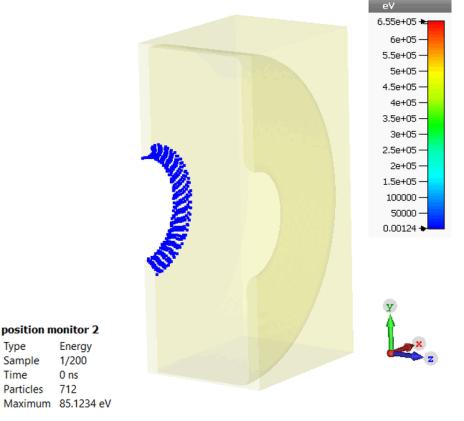
[4] Jorge Giner Navarro. Breakdown studies for high gradient RF warm technology in: CLIC and hadrontherapy linacs. PhD thesis, Universitat de València, 2016.

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## Field emission in a single cell of a CLIC T24

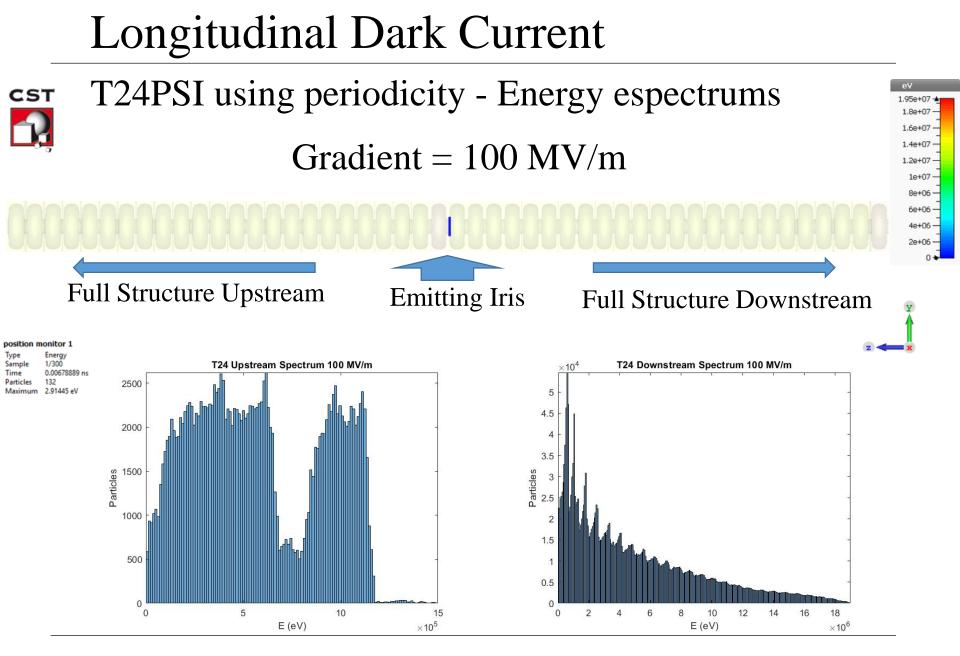
In this animation we present a closer look to the trajectories of the electrons emitted in the left iris.

The particle simulations presented in this work have been carried out with CST particle in cell solver.

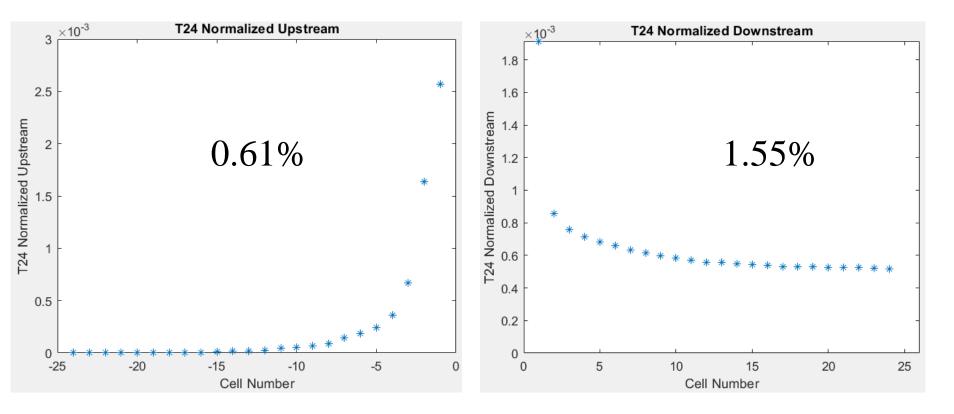


Type

Time

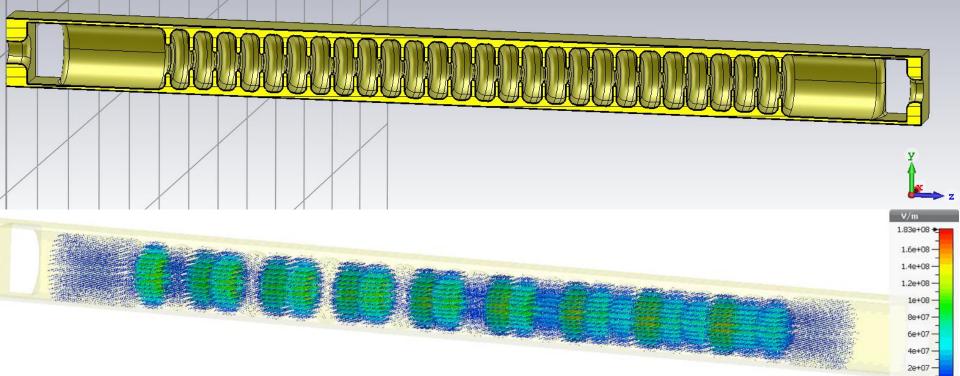


T24PSI using periodicity - Current along the structure





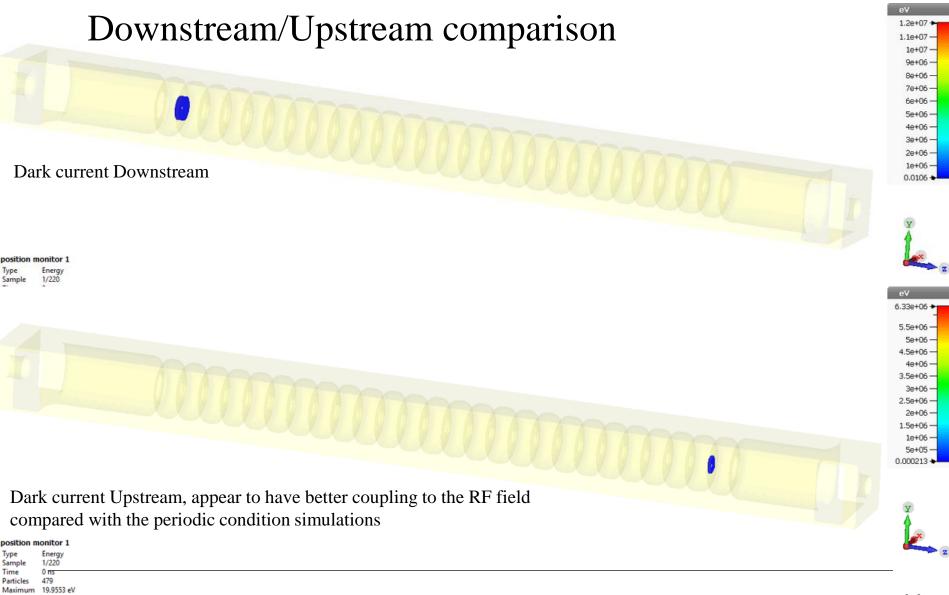
### T24PSI using full field

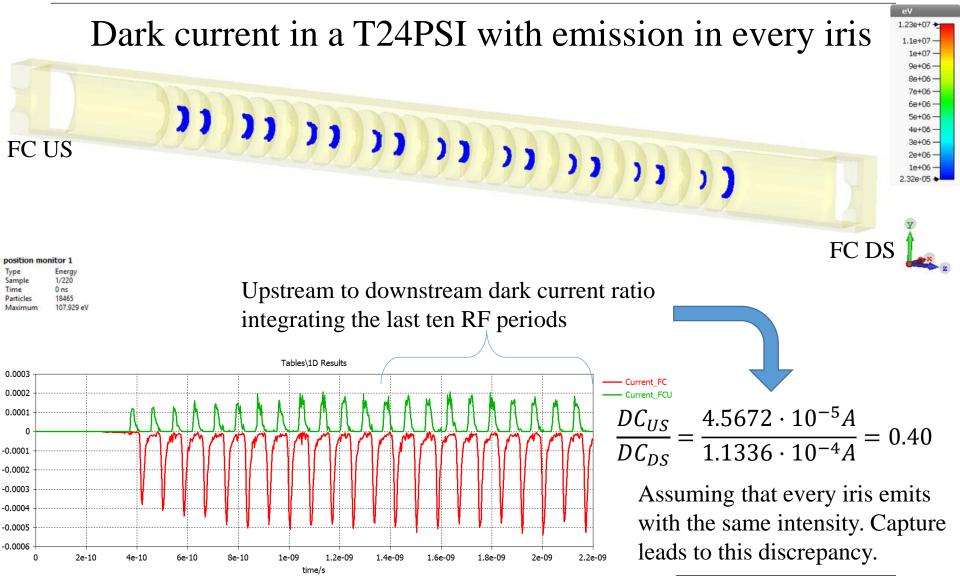


Predefined electric field

Frequency 1.1994e+10 GHz Phase 1 Maximum 1.83241e+08 V/m

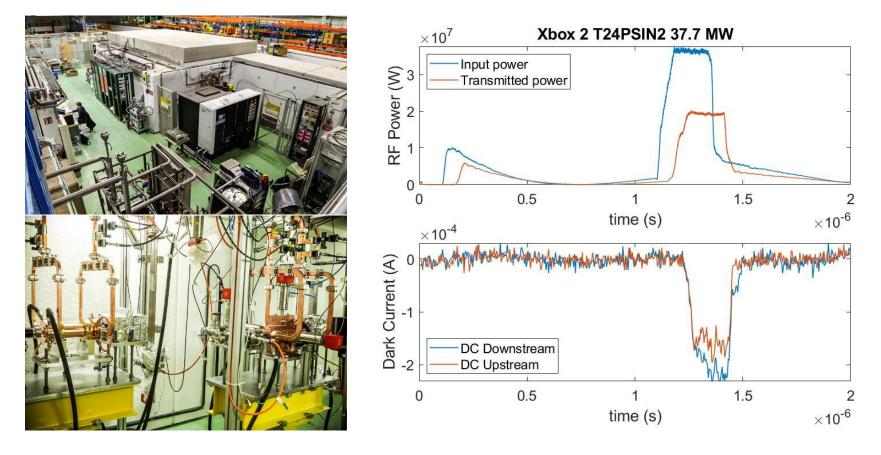
MeVArc 2019





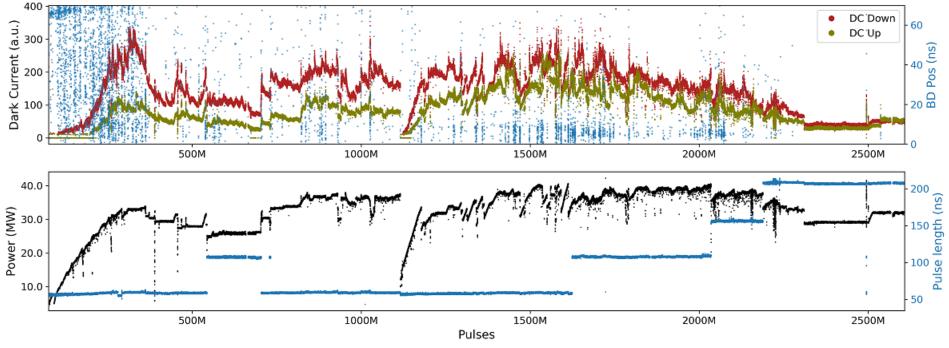
#### Dark current measurements in the xboxes

In the high gradient test stands at CERN we keep track of the dark current measured in the Faraday cups during conditioning of the structures.



#### Dark current measurements in the xboxes

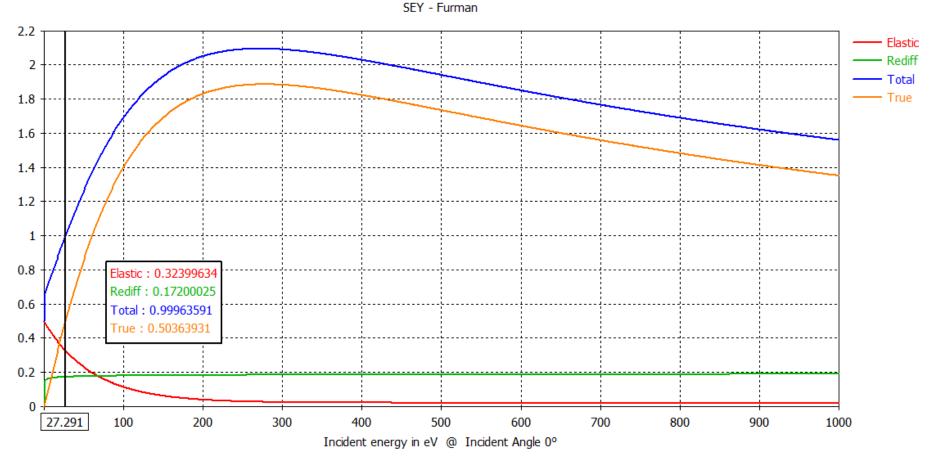
With the post processing of the data recorded we obtain information of the breakdown position and the dark current evolution. If we assume correlation between FE and BD positioning: Emission homogeneously distributed (beginning of conditioning) lead to more downstream dark current. At the end the emission is in the first cells, closer to the upstream FC, and this signal gets comparable to the downstream, even with a much worse capture level.



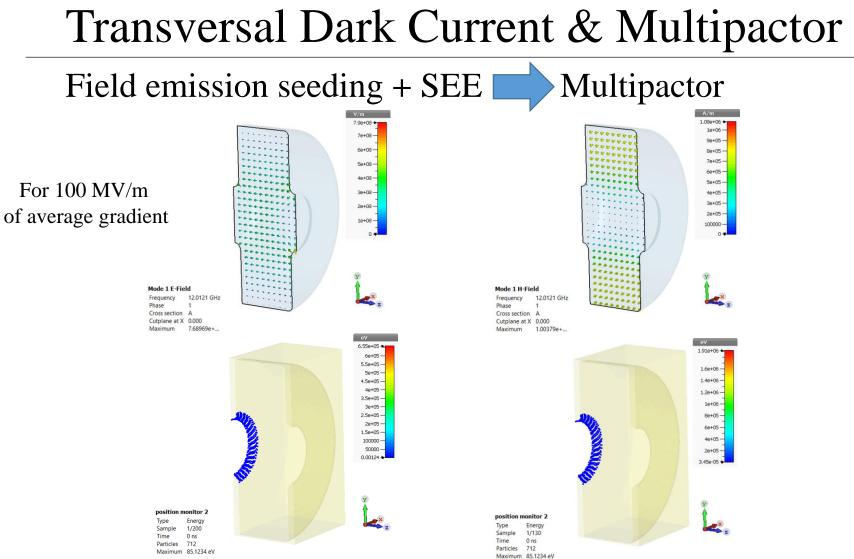
[5] Full conditioning plot of a TD24 CLIC prototype tested in Xbox 3. Graph courtesy of Marcà Boronat.

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#### Secondary Electron Emission Yield

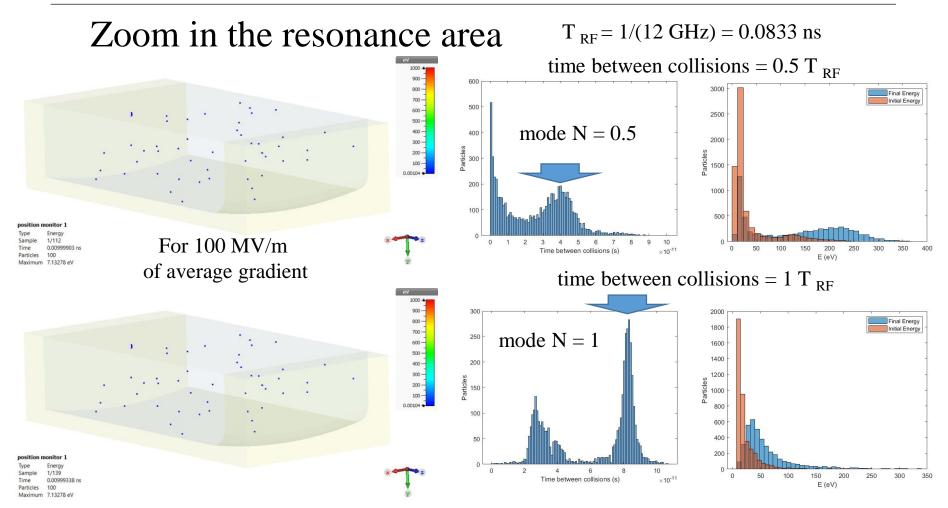


[6] M. A. Furman and M. T. F. Pivi. Probabilistic model for the simulation of secondary electron emission. Physical Review Special Topics – Accelerators and Beams, Vol 5, 124404. 2002.



A complete study of transversal dark current and Multipactor in a HG structure was recently published by a group from MIT, involving simulation and measurements. Please see the reference for more details:

[7] H. Xu, et. al., "Measurements of internal dark current in a 17 GHz, high gradient accelerator structure." PRAB, vol. 22, no. 021002, 2019.



A change in the Multipactor mode normally is determined by a change in the field level or in the initial settings of the particles.

Multipactor mode characterization made by the MIT group, presented in the cited reference

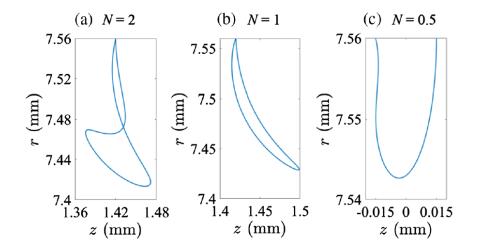


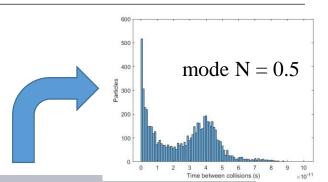
FIG. 6. Sample trajectories of the second-order one-point MP (a) at 45 MV/m, the first-order one-point MP (b) at 72 MV/m, and the first-order two-point MP (c) at 250 MV/m.

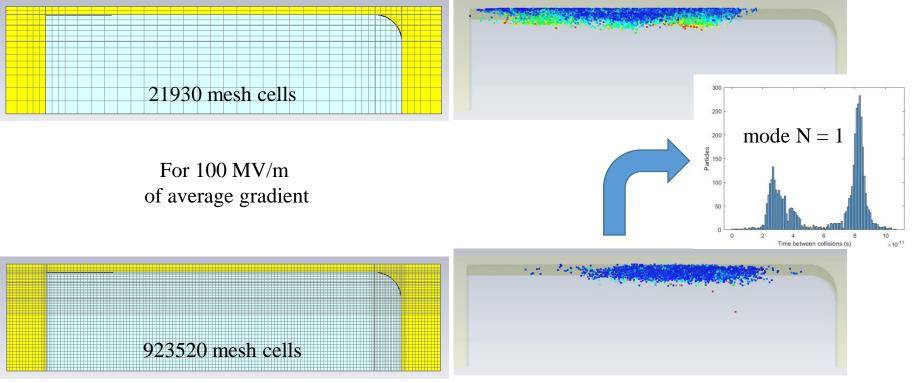
[7] H. Xu, et. al., "Measurements of internal dark current in a 17 GHz, high gradient accelerator structure." PRAB, vol. 22, no. 021002, 2019.

## Zoom in the resonance area

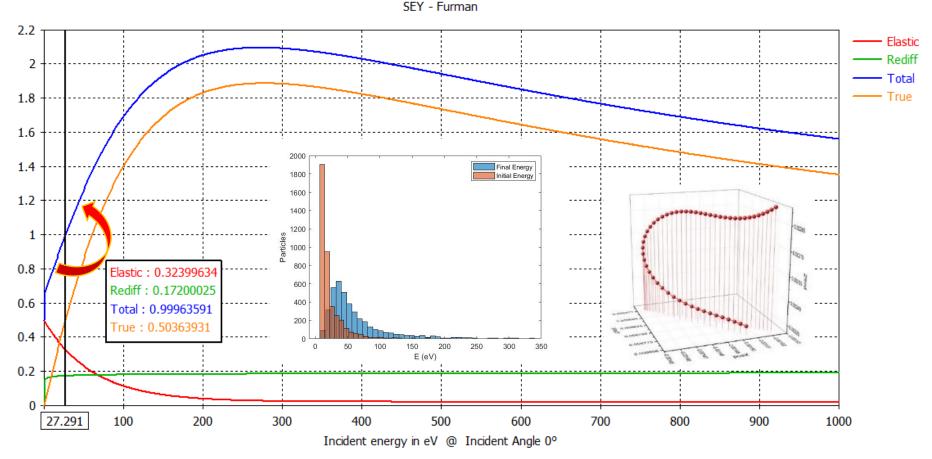
In our case what we changed was the mesh size, keeping the same field level and the same particle source.

Increasing the mesh quality also reduces the time step for the PIC simulation, this can lead to a more precise trajectory calculation, and the possibility of changing the Multipactor mode.





Energy gain in the Multipactor trajectories



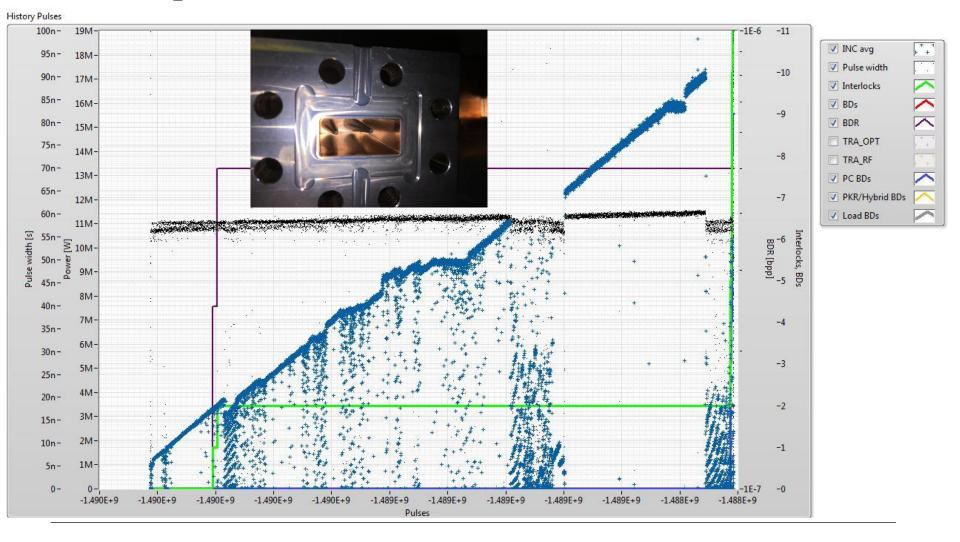
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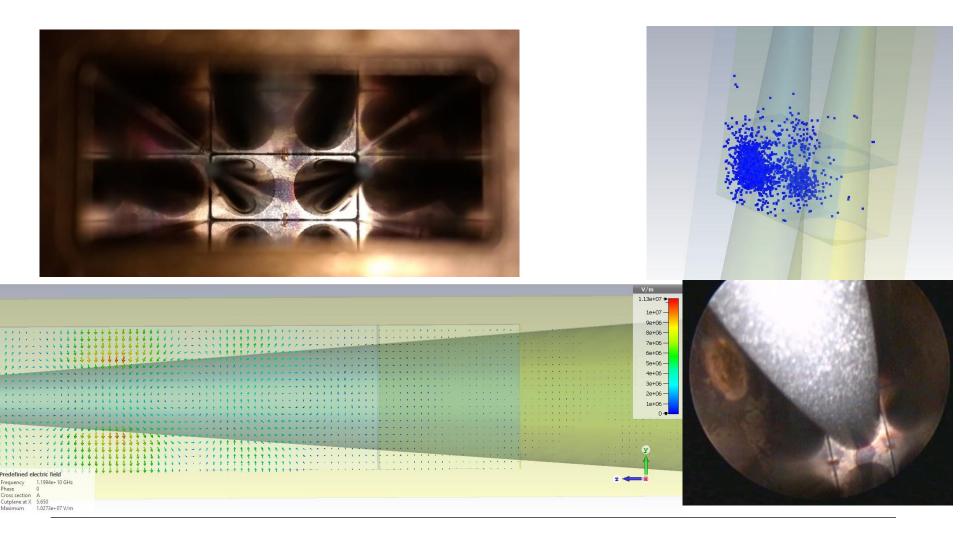
# Multipactor in SiC loads

First experimental results - RF terminators tested at Xbox 3



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# Conclusions

- In this talk the effect of field emission and Multipactor in high gradient structures has been presented. In different scenarios and from theoretical and experimental points of view.
- The longitudinal dark current is measured in the Xboxes for BD detection during conditioning of HG structures. An analysis of the data recorded together with CST simulations is leading to good results. Possible correlation between BD location and emission.
- The Multipactor inside the cell is analyzed from a theoretical point of view, using CST simulations.
- The Multipactor in a silicon carbide loads has been simulated, seems to be evidence also in the postmortem analysis of the components.

# thanks very much for your attention